## **IN THE SPECIFICATION**

Please amend the following paragraph.

[0050] Further detailed information concerning the exemplary nodes illustrated in Figures 5A and 5B can be found in a co-pending U.S. Patent Application No. 10/785,619, now U.S. Patent No. 7,174,066 by Christopher M. Look, having an applicant's reference number of 6518P010, entitled "A Method And An Apparatus To Detect Signal Failure On A Per Wavelength Basis", filed February 23, 2004, and assigned to a common assignee of the present application, which is hereby incorporated by reference.